

FDP3672

N-Channel PowerTrench® MOSFET

105 V, 41 A, 33 mΩ

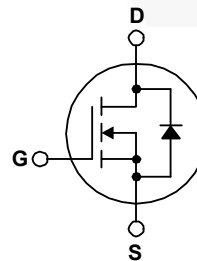
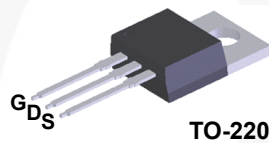
Features

- $R_{DS(on)} = 25 \text{ m}\Omega$ (Typ.) @ $V_{GS} = 10 \text{ V}$, $I_D = 41 \text{ A}$
- $Q_{G(tot)} = 28 \text{ nC}$ (Typ.) @ $V_{GS} = 10 \text{ V}$
- Low Miller Charge
- Low Q_{rr} Body Diode
- Optimized Efficiency at High Frequencies
- UIS Capability (Single Pulse and Repetitive Pulse)

Applications

- Consumer Appliances
- Synchronous Rectification
- Battery Protection Circuit
- Motor drives and Uninterruptible Power Supplies
- Micro Solar Inverter

Formerly developmental type 82760



MOSFET Maximum Ratings $T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	FDP3672	Unit
V_{DSS}	Drain to Source Voltage	105	V
V_{GS}	Gate to Source Voltage	± 20	V
I_D	Drain Current		
	Continuous ($T_C = 25^\circ\text{C}$, $V_{GS} = 10\text{V}$)	41	A
	Continuous ($T_C = 100^\circ\text{C}$, $V_{GS} = 10\text{V}$)	31	A
	Continuous ($T_{amb} = 25^\circ\text{C}$, $V_{GS} = 10\text{V}$, $R_{\theta JA} = 62^\circ\text{C/W}$)	5.9	A
	Pulsed	Figure 4	A
E_{AS}	Single Pulse Avalanche Energy (Note 1)	48	mJ
P_D	Power dissipation	135	W
	Derate above 25°C	0.9	W/ $^\circ\text{C}$
T_J, T_{STG}	Operating and Storage Temperature	-55 to 175	$^\circ\text{C}$

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	1.11	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max. (Note 2)	62	$^\circ\text{C/W}$

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDP3672	FDP3672	TO-220	Tube	N/A	50 units

Electrical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
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Off Characteristics

B_{VDSS}	Drain to Source Breakdown Voltage	$I_D = 250\mu\text{A}$, $V_{GS} = 0\text{V}$	105	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 80\text{V}$ $V_{GS} = 0\text{V}$ $T_C = 150^\circ\text{C}$	-	-	1	μA
I_{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20\text{V}$	-	-	± 100	nA

On Characteristics

$V_{GS(TH)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 250\mu\text{A}$	2	-	4	V
$r_{DS(ON)}$	Drain to Source On Resistance	$I_D = 41\text{A}$, $V_{GS} = 10\text{V}$	-	0.025	0.033	Ω
		$I_D = 21\text{A}$, $V_{GS} = 6\text{V}$,	-	0.031	0.055	
		$I_D = 41\text{A}$, $V_{GS} = 10\text{V}$, $T_C = 175^\circ\text{C}$	-	0.063	0.070	

Dynamic Characteristics

C_{ISS}	Input Capacitance	$V_{DS} = 25\text{V}$, $V_{GS} = 0\text{V}$, $f = 1\text{MHz}$	-	1670	-	pF
C_{OSS}	Output Capacitance		-	240	-	pF
C_{RSS}	Reverse Transfer Capacitance		-	55	-	pF
$Q_{g(TOT)}$	Total Gate Charge at 10V	$V_{GS} = 0\text{V}$ to 10V	-	28	37	nC
$Q_{g(TH)}$	Threshold Gate Charge	$V_{GS} = 0\text{V}$ to 2V	-	3.9	5	nC
Q_{gs}	Gate to Source Gate Charge	$V_{DD} = 50\text{V}$ $I_D = 41\text{A}$ $I_g = 1.0\text{mA}$	-	12	-	nC
Q_{gs2}	Gate Charge Threshold to Plateau		-	8.0	-	nC
Q_{gd}	Gate to Drain "Miller" Charge		-	6.5	-	nC

Resistive Switching Characteristics ($V_{GS} = 10\text{V}$)

t_{ON}	Turn-On Time	$V_{DD} = 50\text{V}$, $I_D = 41\text{A}$ $V_{GS} = 10\text{V}$, $R_{GS} = 11.0\Omega$	-	-	90	ns
$t_{d(ON)}$	Turn-On Delay Time		-	12	-	ns
t_r	Rise Time		-	48	-	ns
$t_{d(OFF)}$	Turn-Off Delay Time		-	24	-	ns
t_f	Fall Time		-	27	-	ns
t_{OFF}	Turn-Off Time		-	-	77	ns

Drain-Source Diode Characteristics

V_{SD}	Source to Drain Diode Voltage	$I_{SD} = 41\text{A}$	-	-	1.25	V
		$I_{SD} = 21\text{A}$	-	-	1.0	V
t_{rr}	Reverse Recovery Time	$I_{SD} = 41\text{A}$, $dI_{SD}/dt = 100\text{A}/\mu\text{s}$	-	-	39	ns
Q_{RR}	Reverse Recovered Charge	$I_{SD} = 41\text{A}$, $dI_{SD}/dt = 100\text{A}/\mu\text{s}$	-	-	42	nC

Notes:

1: Starting $T_J = 25^\circ\text{C}$, $L = 0.11\text{mH}$, $I_{AS} = 30\text{A}$.

2: Pulse Width = 100s

Typical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

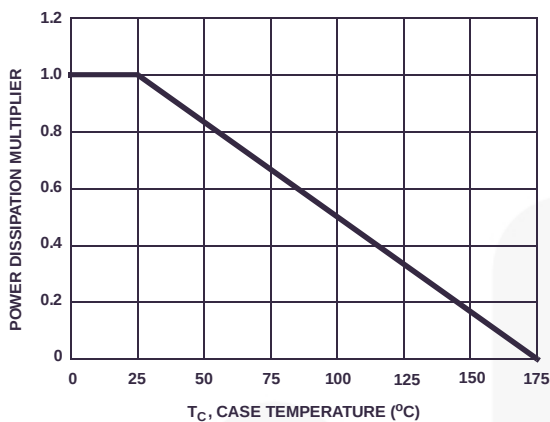


Figure 1. Normalized Power Dissipation vs Ambient Temperature

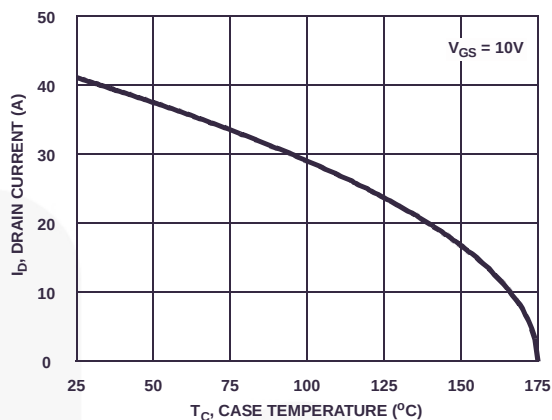


Figure 2. Maximum Continuous Drain Current vs Case Temperature

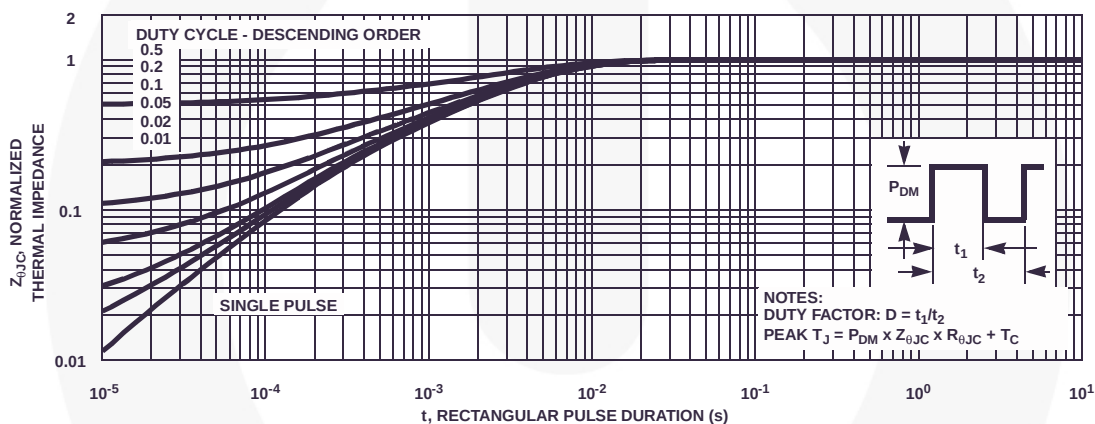


Figure 3. Normalized Maximum Transient Thermal Impedance

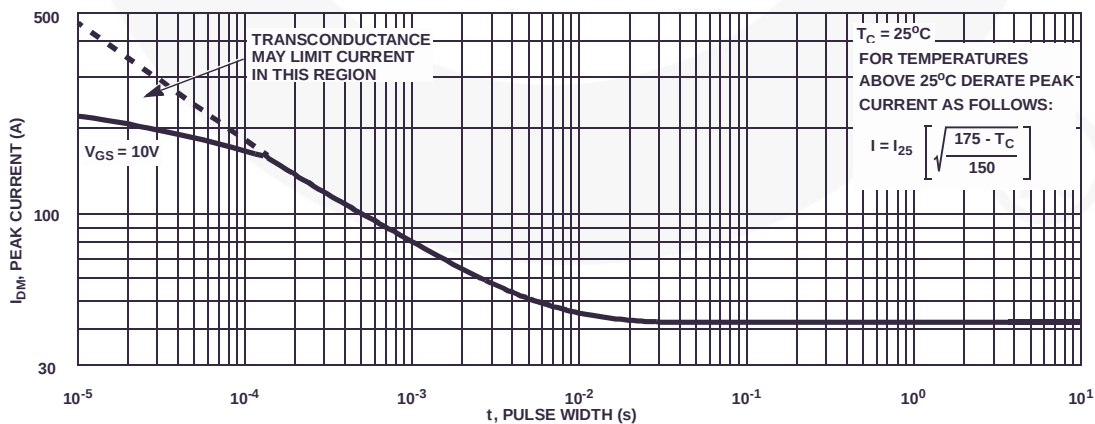


Figure 4. Peak Current Capability

Typical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

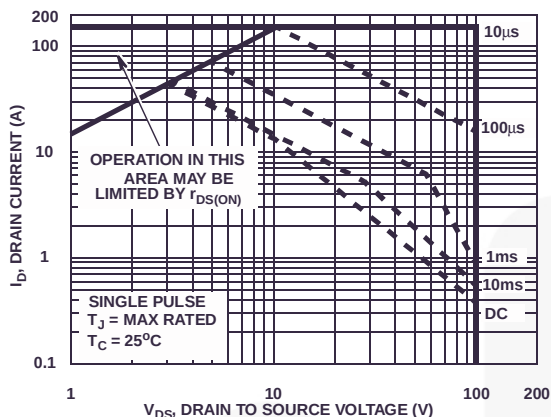
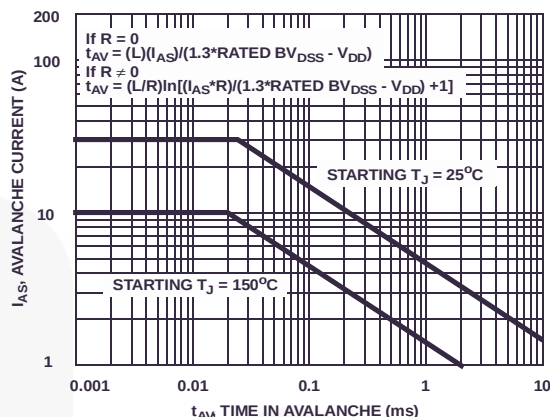


Figure 5. Forward Bias Safe Operating Area



NOTE: Refer to Fairchild Application Notes AN7514 and AN7515
Figure 6. Unclamped Inductive Switching Capability

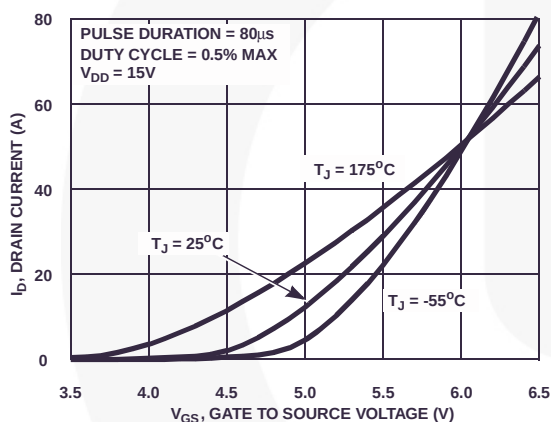


Figure 7. Transfer Characteristics

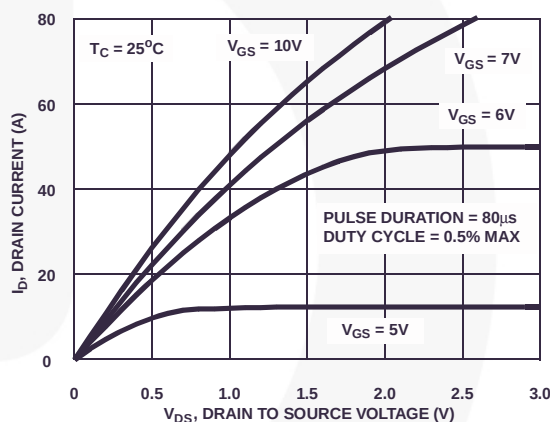


Figure 8. Saturation Characteristics

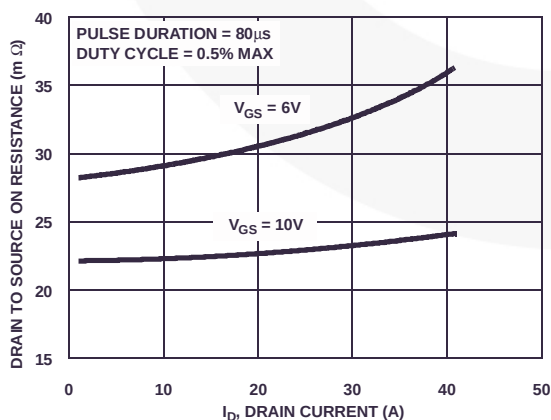


Figure 9. Drain to Source On Resistance vs Drain Current

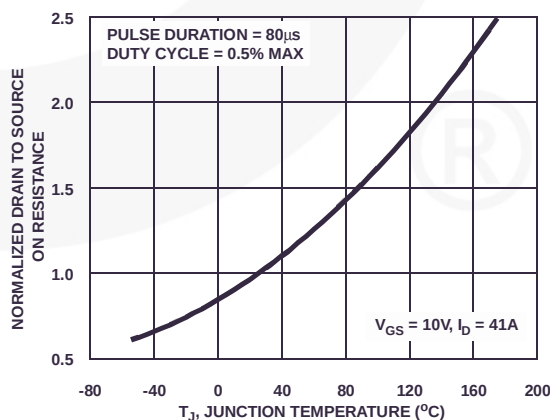


Figure 10. Normalized Drain to Source On Resistance vs Junction Temperature

Typical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

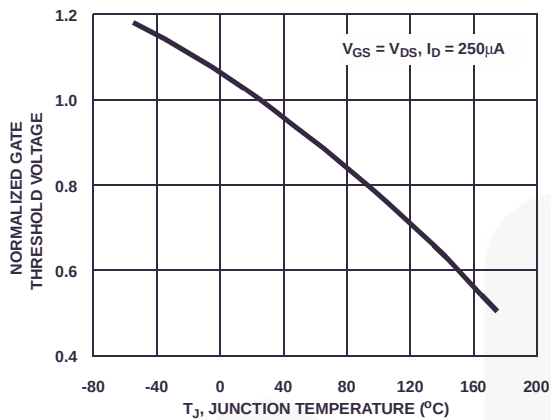


Figure 11. Normalized Gate Threshold Voltage vs Junction Temperature

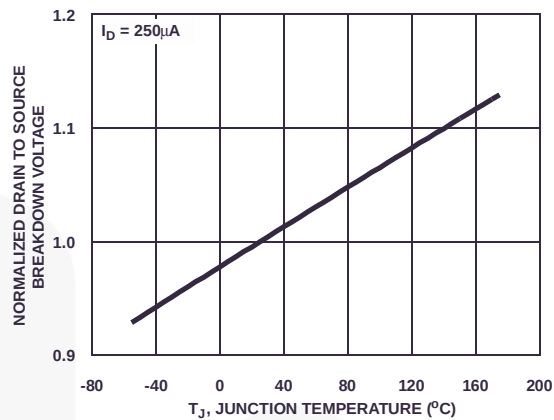


Figure 12. Normalized Drain to Source Breakdown Voltage vs Junction Temperature

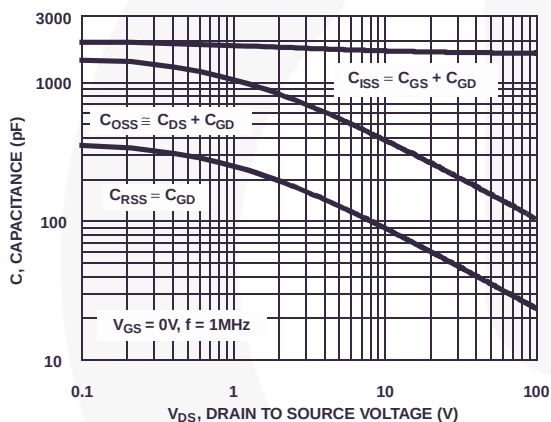


Figure 13. Capacitance vs Drain to Source Voltage

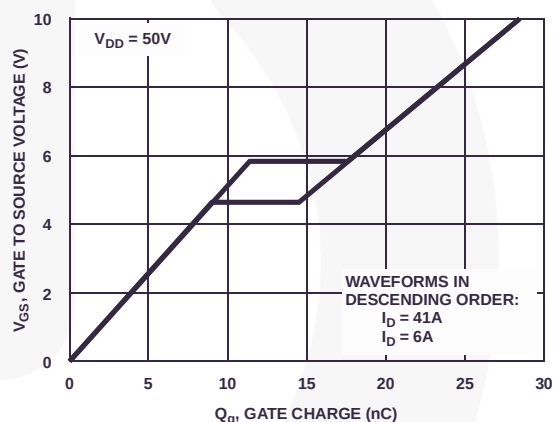


Figure 14. Gate Charge Waveforms for Constant Gate Currents

Test Circuits and Waveforms

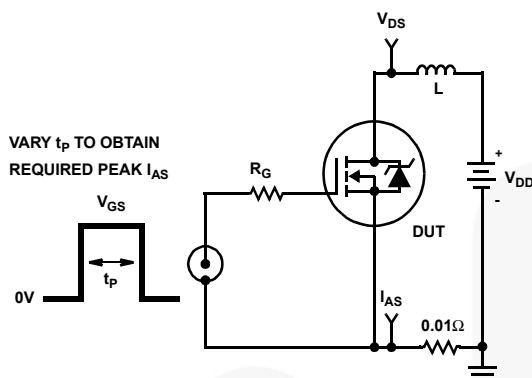


Figure 15. Unclamped Energy Test Circuit

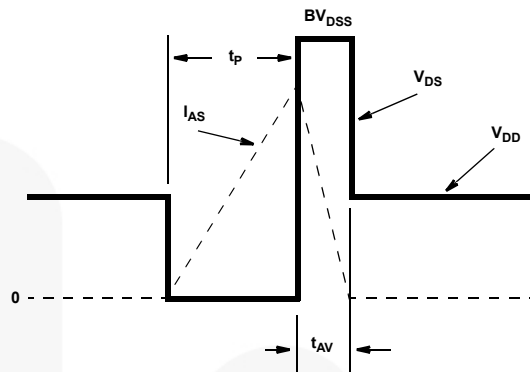


Figure 16. Unclamped Energy Waveforms

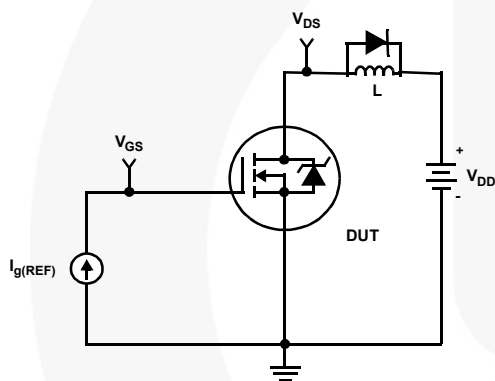


Figure 17. Gate Charge Test Circuit

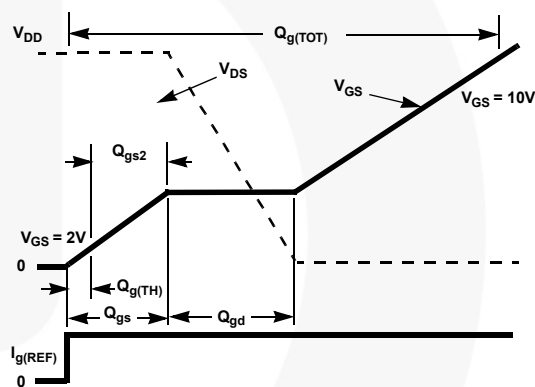


Figure 18. Gate Charge Waveforms

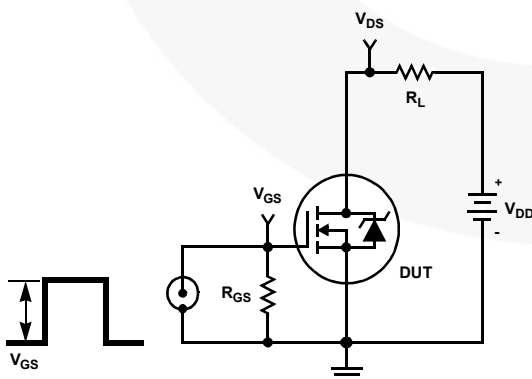


Figure 19. Switching Time Test Circuit

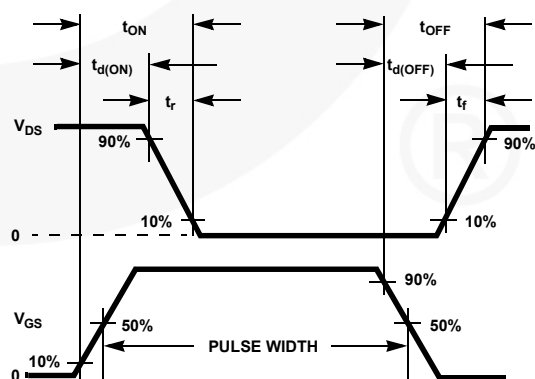


Figure 20. Switching Time Waveforms

PSPICE Electrical Model

.SUBCKT FDP3672 2 1 3 ; rev October 2002

Ca 12 8 5.8e-10

Cb 15 14 6.8e-10

Cin 6 8 1.6e-9

Dbody 7 5 DbodyMOD

Dbreak 5 11 DbreakMOD

Dplcap 10 5 DplcapMOD

Ebreak 11 7 17 18 105

Eds 14 8 5 8 1

Egs 13 8 6 8 1

Esg 6 10 6 8 1

Evthres 6 21 19 8 1

Evtemp 20 6 18 22 1

It 8 17 1

Lgate 1 9 9.56e-9

Ldrain 2 5 1.0e-9

Lsource 3 7 4.45e-9

RLgate 1 9 95.6

RLdrain 2 5 10

RLsource 3 7 44.5

Mmed 16 6 8 8 MmedMOD

Mstro 16 6 8 8 MstroMOD

Mweak 16 21 8 8 MweakMOD

Rbreak 17 18 RbreakMOD 1

Rdrain 50 16 RdrainMOD 6.0e-3

Rgate 9 20 1.5

RSLC1 5 51 RSLCMOD 1.0e-6

RSLC2 5 50 1.0e3

Rsource 8 7 RsourceMOD 9.5e-3

Rvthres 22 8 RvthresMOD 1

Rvtemp 18 19 RvtempMOD 1

S1a 6 12 13 8 S1AMOD

S1b 13 12 13 8 S1BMOD

S2a 6 15 14 13 S2AMOD

S2b 13 15 14 13 S2BMOD

Vbat 22 19 DC 1

ESLC 51 50 VALUE={(V(5,51)/ABS(V(5,51)))*(PWR(V(5,51)/(1e-6*98),3))}

.MODEL DbodyMOD D (IS=1.0E-11 N=1.05 RS=3.7e-3 TRS1=2.5e-3 TRS2=1.0e-6
+ CJO=1.2e-9 M=0.58 TT=3.75e-8 XTI=4.0)

.MODEL DbreakMOD D (RS=15 TRS1=4.0e-3 TRS2=-5.0e-6)

.MODEL DplcapMOD D (CJO=3.8e-10 IS=1.0e-30 N=10 M=0.60)

.MODEL MmedMOD NMOS (VTO=3.6 KP=3 IS=1e-40 N=10 TOX=1 L=1u W=1u RG=1.5)

.MODEL MstroMOD NMOS (VTO=4.3 KP=59 IS=1e-30 N=10 TOX=1 L=1u W=1u)

.MODEL MweakMOD NMOS (VTO=3.09 KP=0.05 IS=1e-30 N=10 TOX=1 L=1u W=1u RG=15 RS=0.1)

.MODEL RbreakMOD RES (TC1=9.0e-4 TC2=-1.0e-7)

.MODEL RdrainMOD RES (TC1=11.0e-3 TC2= 6.1e-5)

.MODEL RSLCMOD RES (TC1=3.0e-3 TC2=1.0e-6)

.MODEL RsourceMOD RES (TC1=4.0e-3 TC2=1.0e-6)

.MODEL RvthresMOD RES (TC1=-3.5e-3 TC2=-1.5e-5)

.MODEL RvtempMOD RES (TC1=-4.3e-3 TC2=1.5e-6)

.MODEL S1AMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=-5.0 VOFF=-3.5)

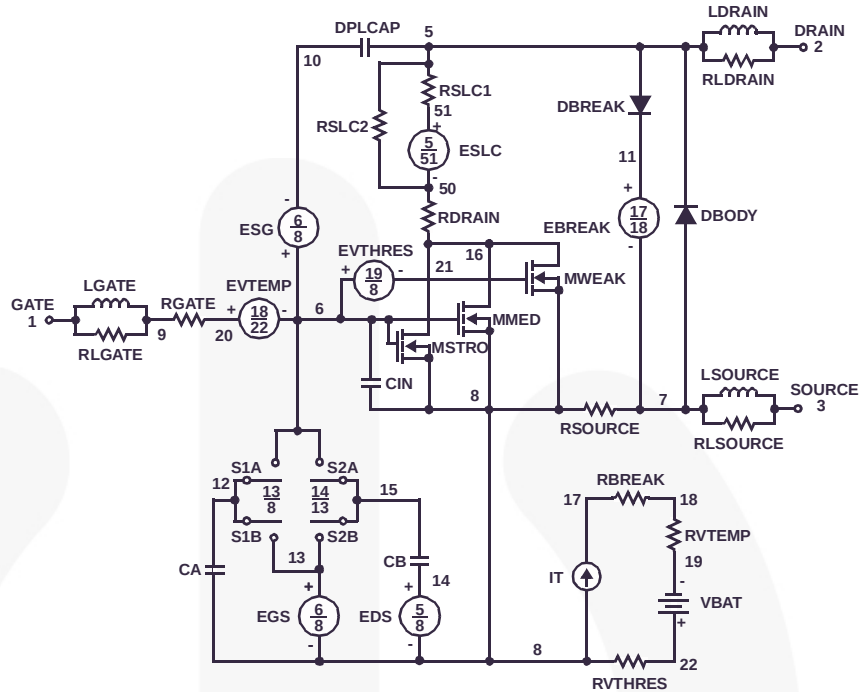
.MODEL S1BMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=-3.5 VOFF=-5.0)

.MODEL S2AMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=-0.5 VOFF=0.3)

.MODEL S2BMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=0.3 VOFF=-0.5)

.ENDS

Note: For further discussion of the PSPICE model, consult **A New PSPICE Sub-Circuit for the Power MOSFET Featuring Global Temperature Options**; IEEE Power Electronics Specialist Conference Records, 1991, written by William J. Hepp and C. Frank Wheatley.



SPICE Thermal Model

REV October 2002

FDP3672

CTHERM1 TH 6 3.2e-3
 CTHERM2 6 5 3.3e-3
 CTHERM3 5 4 3.4e-3
 CTHERM4 4 3 3.5e-3
 CTHERM5 3 2 6.4e-3
 CTHERM6 2 TL 1.9e-2

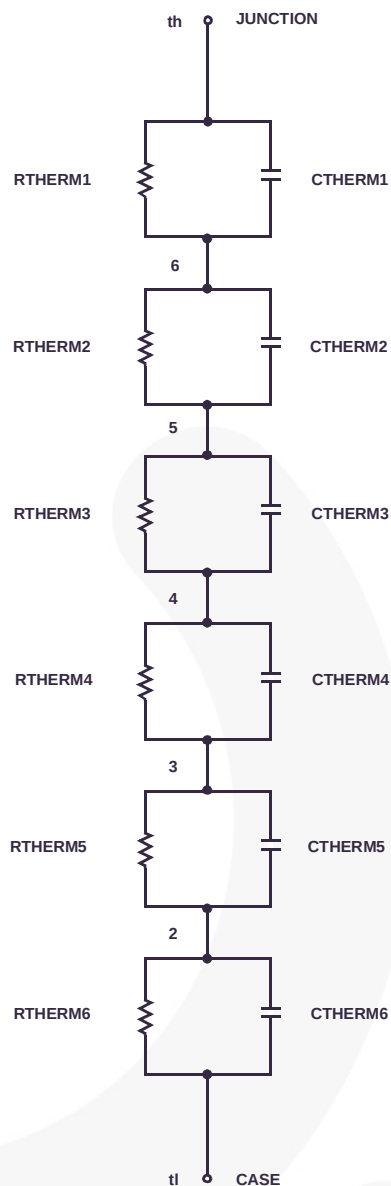
RTHERM1 TH 6 5.5e-4
 RTHERM2 6 5 5.0e-3
 RTHERM3 5 4 4.5e-2
 RTHERM4 4 3 10.5e-2
 RTHERM5 3 2 3.4e-1
 RTHERM6 2 TL 3.5e-1

SABER Thermal Model

SABER thermal model FDP3672
 template thermal_model th tl
 thermal_c th, tl

```
{
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  ctherm.ctherm2 6 5 =3.3e-3
  ctherm.ctherm3 5 4 =3.4e-3
  ctherm.ctherm4 4 3 =3.5e-3
  ctherm.ctherm5 3 2 =6.4e-3
  ctherm.ctherm6 2 tl =1.9e-2
```

```
rtherm.rtherm1 th 6 =5.5e-4
rtherm.rtherm2 6 5 =5.0e-3
rtherm.rtherm3 5 4 =4.5e-2
rtherm.rtherm4 4 3 =10.5e-2
rtherm.rtherm5 3 2 =3.4e-1
rtherm.rtherm6 2 tl =3.5e-1
}
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Mechanical Dimensions

TO-220 3L

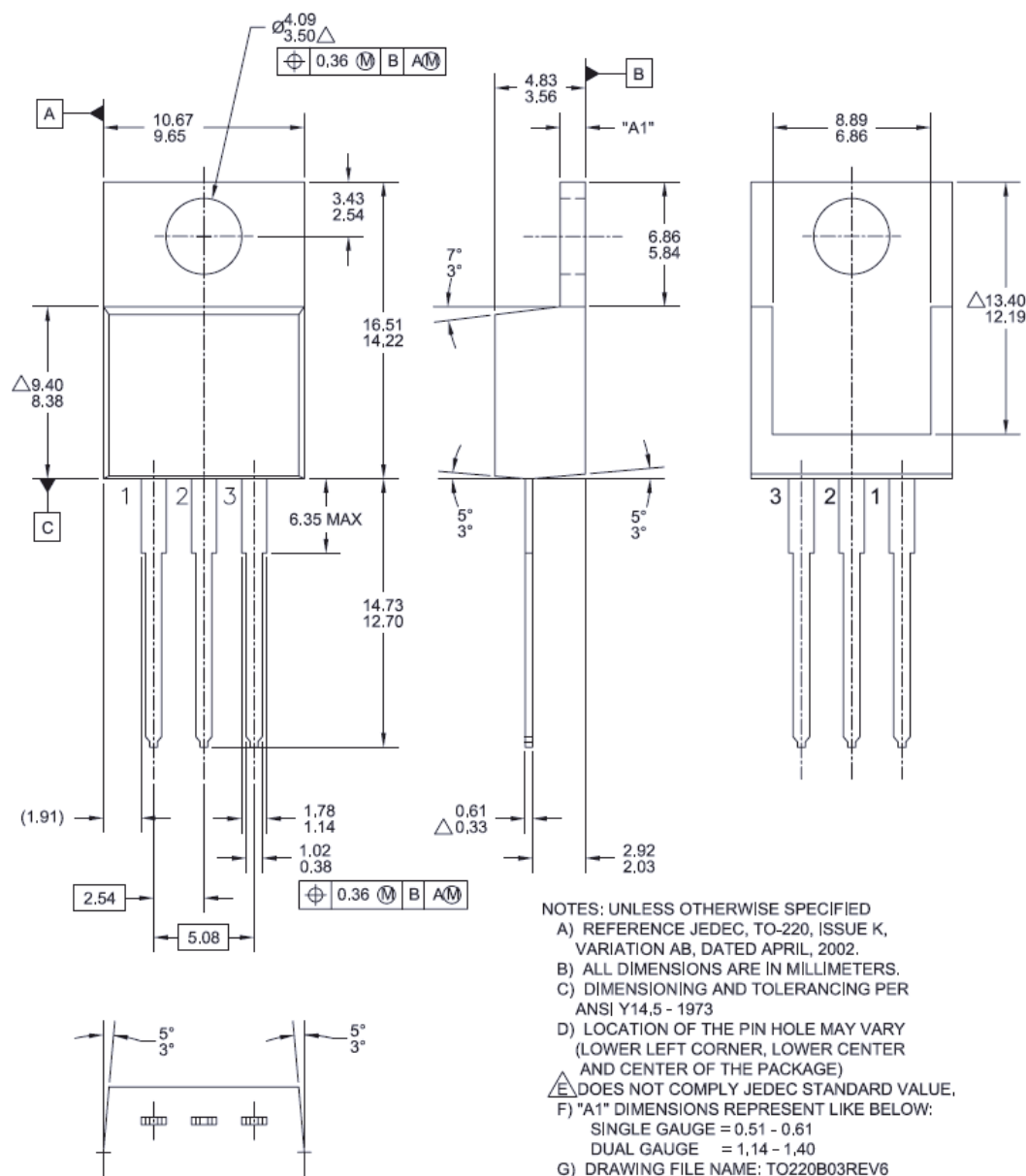


Figure 21. TO-220, Molded, 3Lead, Jedec Variation AB

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Dimension in Millimeters



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CorePOWER™	Green FPS™ e-Series™	Quiet Series™	TinyLogic®
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EcoSPARK®	MegaBuck™		TriFault Detect™
EfficientMax™	MICROCOUPLER™		TRUECURRENT®*
ESBC™	MicroFET™		µSerDes™
	MicroPak™		
Fairchild®	MicroPak2™		UHC®
Fairchild Semiconductor®	MillerDrive™		Ultra FRFET™
FACT Quiet Series™	MotionMax™		UniFET™
FACT®	mWSaver®		VCX™
FAST®	OptoHiT™		VisualMax™
FastvCore™	OPTOLOGIC®		VoltagePlus™
FETBench™	OPTOPLANAR®		XS™
FPS™			

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2. A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
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